

## AO3404A

# **N-Channel Enhancement Mode Field Effect Transistor**



## **General Description**

The AO3404A uses advanced trench technology to provide excellent  $R_{\rm DS(ON)}$  and low gate charge. This device is suitable for use as a load switch or in PWM applications. The source leads are separated to allow a Kelvin connection to the source, which may be used to bypass the source inductance. Standard Product AO3404A is Pb-free (meets ROHS & Sony 259 specifications).

## **Features**

 $V_{DS}(V) = 30V$ 

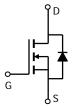
 $I_D = 5.8A$   $(V_{GS} = 10V)$ 

 $R_{DS(ON)}$  < 28m $\Omega$  (V<sub>GS</sub> = 10V)

 $R_{DS(ON)} < 42m\Omega$  (V<sub>GS</sub> = 4.5V)

Rg,Ciss,Coss,Crss Tested





Absolute Maximum Ratings T <sub>A</sub> =25°C unless otherwise noted								
Parameter		Symbol	Maximum	Units				
Drain-Source Voltage		$V_{DS}$	30	V				
Gate-Source Voltage		$V_{GS}$	±20	V				
Continuous Drain	T <sub>A</sub> =25°C		5.8					
Current A,F	T <sub>A</sub> =70°C	$I_D$	4.9	Α				
Pulsed Drain Current <sup>B</sup>		$I_{DM}$	30					
	T <sub>A</sub> =25°C	$P_{D}$	1.4	W				
Power Dissipation	T <sub>A</sub> =70°C	]' □ [	0.9	VV				
Junction and Storage Temperature Range		$T_J$ , $T_{STG}$	-55 to 150	°C				

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient <sup>A</sup>	t ≤ 10s	D	65	90	°C/W			
Maximum Junction-to-Ambient <sup>A</sup>	Steady-State R <sub>0JA</sub>		85	125	°C/W			
Maximum Junction-to-Lead <sup>C</sup>	Steady-State	$R_{\theta JL}$	43	80	°C/W			

### Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
STATIC F	PARAMETERS					
$BV_{DSS}$	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	30			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =30V, V <sub>GS</sub> =0V			1	μА
		T <sub>J</sub> =55°C			5	μιτ
$I_{GSS}$	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ = ±20V			100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ $I_{D}=250\mu A$	1	1.6	3	V
$I_{D(ON)}$	On state drain current	$V_{GS}$ =4.5V, $V_{DS}$ =5V	30			Α
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =5.8A		23.4	28	mΩ
		T <sub>J</sub> =125°C		33	40	1115.2
		V <sub>GS</sub> =4.5V, I <sub>D</sub> =4.8A		33.5	42	mΩ
g <sub>FS</sub>	Forward Transconductance	VDS=5V, ID=5.8A		20		S
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =1A,V <sub>GS</sub> =0V		0.75	1	V
I <sub>S</sub>	Maximum Body-Diode Continuous Curre			1.8	Α	
DYNAMIC	PARAMETERS					
C <sub>iss</sub>	Input Capacitance			621	820	pF
C <sub>oss</sub>	Output Capacitance	$V_{GS}$ =0V, $V_{DS}$ =15V, f=1MHz		118		pF
$C_{rss}$	Reverse Transfer Capacitance			85		pF
$R_g$	Gate resistance	$V_{GS}$ =0V, $V_{DS}$ =0V, f=1MHz		0.8	1.5	Ω
SWITCHI	NG PARAMETERS					
Q <sub>g</sub> (10V)	Total Gate Charge			11.3	17	nC
Q <sub>g</sub> (4.5V)	Total Gate Charge	VCS-10V VDS-15V ID-5 9A		5.7		nC
$Q_{gs}$	Gate Source Charge	VGS=10V, VDS=15V, ID=5.8A		2.1		nC
$Q_{gd}$	Gate Drain Charge			3		nC
t <sub>D(on)</sub>	Turn-On DelayTime			4.5	6.5	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =15V, $R_L$ =2.6 $\Omega$ ,		3.1		ns
t <sub>D(off)</sub>	Turn-Off DelayTime	$R_{GEN}$ =3 $\Omega$		15.1		ns
t <sub>f</sub>	Turn-Off Fall Time			2.7		ns
t <sub>rr</sub>	Body Diode Reverse Recovery Time	IF=5.8A, dI/dt=100A/ms		15.5	21	ns
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	IF=5.8A, dI/dt=100A/ms		7.1		nC

A: The value of  $R_{0JA}$  is measured with the device mounted on  $1\text{in}^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A$ =25°C. The value in any given application depends on the user's specific board design. The current rating is based on the  $t \leq 10$ s thermal resistance rating.

Rev0: Nov. 2006

### Rev0. Apr.2007

THIS PRODUCT HAS BEEN DESIGNED AND QUALIFIED FOR THE CONSUMER MARKET. APPLICATIONS OR USES AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS ARE NOT AUTHORIZED. AOS DOES NOT ASSUME ANY LIABILITY ARISING OUT OF SUCH APPLICATIONS OR USES OF ITS PRODUCTS. AOS RESERVES THE RIGHT TO IMPROVE PRODUCT DESIGN, FUNCTIONS AND RELIABILITY WITHOUT NOTICE.

B: Repetitive rating, pulse width limited by junction temperature.

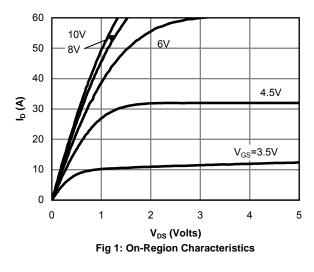
C. The R  $_{\theta JA}$  is the sum of the thermal impedence from junction to lead R $_{\theta JL}$  and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using <300  $\mu s$  pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in  $^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A$ =25°C. The SOA curve provides a single pulse rating.

F.The current rating is based on the  $\bowtie$  10s thermal resistance rating.

### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



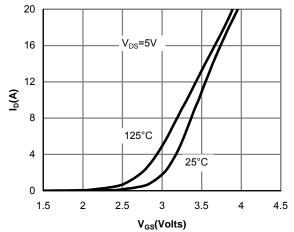


Figure 2: Transfer Characteristics

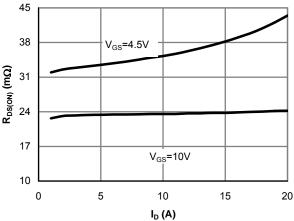


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

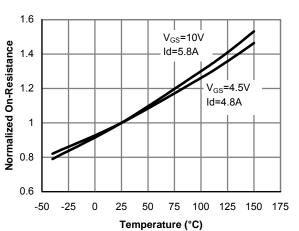


Figure 4: On-Resistance vs. Junction Temperature

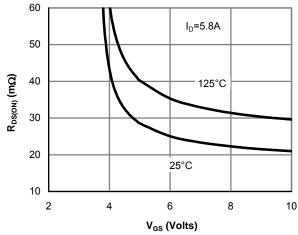


Figure 5: On-Resistance vs. Gate-Source Voltage

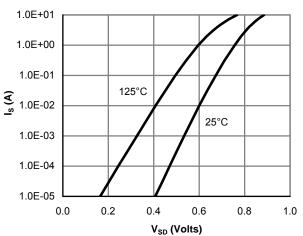


Figure 6: Body-Diode Characteristics

### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

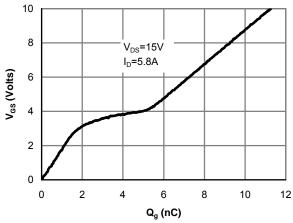


Figure 7: Gate-Charge Characteristics

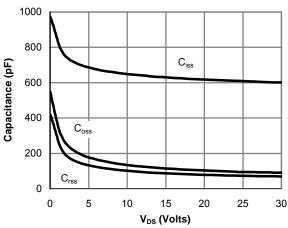


Figure 8: Capacitance Characteristics

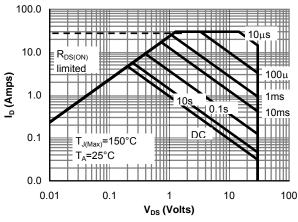


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

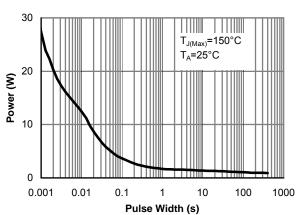


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

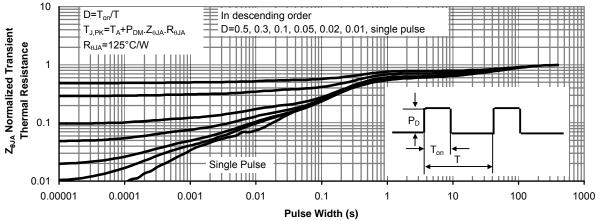


Figure 11: Normalized Maximum Transient Thermal Impedance